

Notice of References Cited		Application/Control No. 10/693,416	Applicant(s)/Patent Under Reexamination YOON ET AL.	
		Examiner VENKATESH HALIYUR	Art Unit 2619	Page 1 of 1

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-6,842,463	01-2005	Drwiega et al.	370/468
*	B US-7,296,288	11-2007	Hill et al.	726/2
*	C US-2002/0031462	03-2002	Jorgensen, Anders Jorn Fjendbo	422/307
*	D US-2003/0086425	05-2003	Bearden et al.	370/392
*	E US-2003/0091165	05-2003	Bearden et al.	379/88,08
*	F US-2003/0097438	05-2003	Bearden et al.	709/224
*	G US-6,591,299	07-2003	Riddle et al.	709/224
*	H US-6,085,238	07-2000	Yuasa et al.	709/223
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
T					

NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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X	

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